

Notice of References Cited	Application/Control No. 10/077,192	Applicant(s)/Patent Under Reexamination LAWRENCE ET AL.	
	Examiner Tan Dean D. Nguyen	Art Unit 3629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2001/0026609	10-2001	Weinstein et al.	379/93.01
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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